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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/753,673	01/07/2004	I-Sheng Liu	M-15281 US	6785

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EXAMINER

MONDT, JOHANNES P

ART UNIT PAPER NUMBER

3663

DATE MAILED: 10/26/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/753,673

Applicant(s)

LIU ET AL.

Examiner

Johannes P. Mondt

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 25 July 2005 and 11 August 2005.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-14 is/are pending in the application.
- 4a) Of the above claim(s) 10-14 is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-9 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Response to Notice of Non-Compliant Amendment (under 35 USC 1.121) filed 8/11/05 in conjunction with Applicant's arguments filed 7/25/05 forms the basis for this office action. Applicant substantially amended all pending claims 1-8 through substantial amendment of claim 1. Comments on Remarks are included below under "Response to Arguments".

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

1. ***Claims 1-3, 6, 7 and 9*** are rejected under 35 U.S.C. 103(a) as being unpatentable over Chang et al (5,912,842) in view of Chindalore et al (US 2004/0070030 A1). *Chang et al* teach a two-transistor PMOS memory cell (see title and abstract, first sentence), comprising: a PMOS select transistor 40b (col. 4, l. 2 and Figure 3) having a drain and source 50 and 48, respectively (cf. col. 4, l. 3-7), formed as separate P+ diffusion regions in an N- well 42 (col. 4, l. 2); a PMOS floating gate transistor 40a (cf. col. 4, l. 1) having a drain and a source 46 and 48 (cf. col. 4, l. 6-9) formed as separate P+ diffusion regions in the N- well, wherein the P+ diffusion region 48 that forms the floating gate transistor's drain is the same P+ diffusion region that forms the select gate transistor's source (col. 4, l. 4-6).

Chang et al do not necessarily teach an N implant underlying the P+ diffusion region that forms the floating gate transistor's drain.

*However, it would have been obvious to teach an implant underlying the heavily doped drain diffusion region of the floating gate in view of Chindalore et al, who, in a patent on a floating gate (see paragraphs [0003] and [0021]) for non-volatile memory devices, -hence analogous art, teach in particular the prevention of punch-through through the inclusion of a halo implant 46 underlying the drain region 54 of said floating gate 32 only (cf. [0014]), said halo implant being of opposite conductivity type in comparison to said drain region. It is exactly the hot-carrier injection in the floating gate stacks in both Chang et al and Chindalore et al that prompts the inclusion by Chindalore et al of the implant of conductivity type opposite to that of source and drain on the drain side (see [0014]), *motivation* for the inclusion of the teaching by Chindalore et al in the invention by Chang et al exists and derives from the resulting additional protection against punch through in floating gates. Because the hot carrier injection is specific to the floating gate one of ordinary skills in the art would consider it obvious to include one halo region underlying the drain of the floating gate stack 10 in Chang et al and nowhere else.*

On claim 2: in the combined invention the lateral extent of the M implant 30 is substantially the same as that of the P+ diffusion region that forms the PMOS floating gate transistor's drain, i.e., region 48, because the tilt angle of the halo implant can be zero degrees (col. 6, l. 33-41)

On claim 3: the drain of the PMOS select transistor 50 couples to a bit line BL0 of a memory array 70 (cf. col. 5, l. 1-15), and a select gate 40 b of the PMOS select transistor couples to a word line WL0 (loc.cit.) of the memory array 70.

On claim 6: the memory cell is configured such that the floating gate transistor may be programmed using band-to-band tunneling because a thin tunnel oxide layer 56 (col. 31-33) is included while the two transistors are PMOS transistors.

On claim 7: Fowler-Nordheim tunneling is implemented in a preferred embodiment in Chang et al (col. 5, l. 63 – col. 7, l. 51).

On claim 9: the thickness of the implant of opposite conductivity type underlying the heavily doped drain diffusion region that forms the floating gate transistor's drain in the combined invention includes a range that overlaps with the range as claimed, because the lateral excursion of said implant by Chindalore is 500 Angstroms (see [0024]) while the implant angle θ is between 20 and 60 degrees (see par. [0024]), while for all implant angles less than 26 degrees the depth is more than twice said lateral excursion, i.e., more than 1000 Angstroms. A *prima facie* case of obviousness typically exists when the ranges of a claimed composition overlap the ranges disclosed in the prior art or when the ranges of a claimed composition do not overlap but are close enough such that one skilled in the art would have expected them to have the same properties. In re Peterson, 65 USPQ2d 1379 (CA FC 2003).

2. **Claim 4** is rejected under 35 U.S.C. 103(a) as being unpatentable over Chang et al and Chindalore et al as applied to claim 2 above, and further in view of Chang et al (5,687,118). In the combined invention by Chang et al and Chindalore et al a floating

gate 54 is formed in a first polysilicon layer (col. 4, l. 8-9). Neither Chang et al nor Chindalore et al necessarily teach the control gate of the PMOS floating gate transistor to be formed of polysilicon. However, it would have been obvious to include the further limitation on the material constitution of said control gate as claimed in view of Chang et al (5,687,118) ("Chang 2" henceforth) who teach in very closely related art the material constitution of the control gate to be polysilicon as well (cf. col. 11, l. 46-56). *Motivation* to include the teaching by Chang2 at least stems from the economy to use the same material for extremely similar structures in the same invention. Furthermore, Applicant is reminded in this regard that it has been held that mere selection of known materials generally understood to be suitable to make a device, the selection of the particular material being on the basis of suitability for the intended use, would be entirely obvious. *In re Leshin* 125 USPQ 416. Chang2 proves that polysilicon for the material selection of the control gate in a floating gate transistor is generally understood to be suitable.

3. **Claim 5** is rejected under 35 U.S.C. 103(a) as being unpatentable over Chang et al and Chindalore et al as applied to claim 2 above, and further in view of Yaegashi et al (US 2002/0098638 A1). As detailed above, claim 2 is unpatentable over Chang et al in view of Chindalore et al *Although Chang et al teach* the memory cell to include a single polysilicon layer containing a floating gate (col. 4, l. 9-11 and Figure 3, *neither Chang nor Chindalore necessarily teach* the further limitation as defined by claim 5. *However, it would have been obvious* to include said further limitation in view of Yaegashi et al who teaches a back-gate as control gate to facilitate erase operations (see paragraph [0347] and Fig. 71). *Motivation* to include the teaching by Yaegashi et al in the invention thus

derives at least from facilitating an operation that is routinely performed by any memory cell including that of the invention.

4. **Claim 8** is rejected under 35 U.S.C. 103(a) as being unpatentable over Chang et al and Chindalore et al as applied to claim 2 above, and further in view of Prall et al (5,345,104). As detailed above, claim 2 is unpatentable over Chang et al in view of Chindalore et al. Neither necessarily teach the further limitations of claim 8. *However, it would have been obvious to include the further limitation as defined by claim 8 in view of Prall et al*, who, in a patent on creating halo regions in a MOSFET with floating gate within the context of a flash memory cell, - hence closely related art, teach the thickness of the drain region 18 of the floating gate's transistor to be approximately 1000 Angstrom = 0.1 micron (cf. col. 3, l. 55-60), which is in the range as recited in claim 8, considering the verbiage "approximately". Applicant is furthermore reminded that a *prima facie* case of obviousness typically exists when the ranges of a claimed quantity overlap the ranges disclosed in the prior art or when the ranges of a claimed quantity do not overlap but are close enough such that one skilled in the art would have expected them to have the same properties. In re Peterson, 65 USPQ2d 1379 (CA FC 2003).

Response to Arguments

Applicant's arguments filed 7/25/05 have been fully considered but they are not persuasive. Although the substantial amendment overcomes the previous rejections new art against the newly amended claim language is herewith presented for the first time possible. Counter to Applicant's argument that "the prior art stands in sharp contrast" to the invention characterized by the newly added claim limitation (see

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Remarks, page 5) because of its teaching of halo regions, and that because "these are halo regions, they underlie both the source and the drain", underlying both source and drain regions is not an inherent aspect of halo regions, as witnessed by Chandalore et al (see abstract, halo region 46 underlying drain region 54 being only on the drain side in a floating gate transistor); while, furthermore, the rationale for inclusion of the halo region is specific to floating gates or SONOS gate stacks and hence does not necessarily apply to select gates (see [0003] and [0021]). Therefore, one of ordinary skills would, on the basis of Chandalore et al include a single halo region underlying the drain region of the floating gate 10 in Chang et al. Therefore, the newly amended claims are herewith rejected over Chang et al (and supplementary references for selected claims as before) in view of Chindalore et al.

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Hoefler (6,713,812 B1).

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire **THREE MONTHS** from the mailing date of this action. In the event a first reply is filed within **TWO MONTHS** of the mailing date of this final action and the advisory action is not

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mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Johannes P. Mondt whose telephone number is 571-272-1919. The examiner can normally be reached on 8:00 - 18:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jack W. Keith can be reached on 571-272-6878. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

JPM
October 17, 2005


JACK KEITH
SUPERVISORY PATENT EXAMINER